Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10526162	MATSUDA ET AL.
Examiner	Art Unit
HENOK G HEYI	2627

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES		
Search Notes	Date	Examiner
Searched EAST, specifically 369/275.1, 275.2, 275.3 and 275.4 (text search only - please see search history printout).	8/13/2008	HH

INTERFERENCE SEARCH			
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